Search Notes

Application/Control No.	Applicant(s)/Patent und Reexamination	er
10/525,733	NAKAJIMA ET AL.	
Examiner	Art Unit	
Lun San Lan	2645	

SEARCHED					
Class	Subclass	Date	Examiner		
[*] 381	67,151	12/18/2006	L.S.		
	_ 70,152				
	326				
	375-				
•	376				
704	271,233				
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	41.2	12/28/2006	L.S.		
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INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)		
•	DATE.	EXMR
EAST	12/18/2006	L.S.
XU MEI	12/18/2006	L.S.
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